


<b>Search Notes</b>  	<b>Application/Control No.</b>  09996120	<b>Applicant(s)/Patent Under Reexamination</b>  CHAN ET AL.
	<b>Examiner</b>  EDNA WONG	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
568	959	6/16/06	EW
205	343	6/16/06	EW
205	427	6/16/06	EW
205	455	6/16/06	EW
205	293	6/16/06	EW
204	403.1	6/16/06	EW
429	218.1	6/16/06	EW
205	413	4/9/08	EW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	6/16/06	EW
EAST	6/16/06	EW
Search Updated	12/29/06	EW
EAST	12/29/06	EW
Search Updated	3/29/07	EW
STN	3/29/07	EW
Search Updated	6/2/07	EW
Search Updated	12/26/07	EW
Search Updated	4/9/08	EW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
205	343	4/12/08	EW
205	427	4/12/08	EW
205	455	4/12/08	EW
205	413	4/12/08	EW